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Patent
42479-7900

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Masayoshi Shinohara

Serial No.: 10/602,501

Filed: June 24, 2003

For: PARTICULATE MATTER
CONCENTRATION MEASURING
APPARATUS

Patent Examiner: Cygan, Michael T.

Group Art Unit: 2855

April 28, 2005

Irvine, California 92614

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sirs:

In order to meet the requirements of 37 C.F.R. §1.56, applicant hereby wishes to bring to the attention of the United States Patent Office references cited within the last three months in a co-pending corresponding Chinese patent application. A copy of the Office Action is attached hereto.

Two references were cited, U.S. Patent No. 5,317,930, which is already of record in the prosecution of the present case, and a Chinese Patent 1317409, attached hereto with an English abstract of a corresponding Japanese patent application to the cited Chinese reference.

Attached is a PTO Form A820 listing the Chinese reference for consideration in the prosecution of this matter.

If there are any questions with regards to the submission, the undersigned attorney can be contacted at the listed phone number.

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to Mail Stop AF, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on April 28, 2005.

By: Sharon Farnus

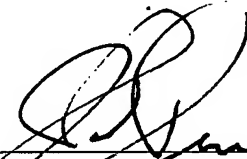


Signature

Dated: April 28, 2005

Very truly yours,

SNELL & WILMER L.L.P.



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INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>				Docket Number (Optional)		Application Number		
				42479-7900		Not yet assigned		
				Applicant(s)				
				Masayoshi Shinohara et al.				
Filing Date				Group Art Unit				
Herewith				Not yet assigned				
U. S. PATENT DOCUMENTS								
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
U. S. PATENT APPLICATION PUBLICATIONS								
EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		2001-347686	18.12.2001	Japan			X	
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>								
		Copy of Chinese Office Action dated April 8, 2005.						
EXAMINER				DATE CONSIDERED				
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								